



# 0.35 µm CMOS Gate Array **CMOS-9HD Family**



Second-generation highly integrated Considerable cost reduction

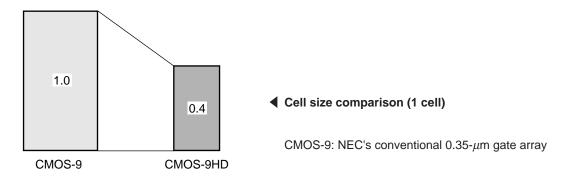


# **FEATURES**

The CMOS-9HD Family is a channel-less type gate array that uses the 0.35- $\mu$ m leading-edge process and realizes 960,000 usable gates. This family is adaptable for both high-speed and low-power consumption systems. Currently supporting a 3.3-V supply voltage, it is expected that the future lineup will be able to support a supply voltage of 2.5 V.

## **High Integration/Low Power Consumption**

- Maximum of 960,000 usable gates integrated
- Improved cell structure, higher density
- Lower power consumption (a further 30% reduction from CMOS-9)



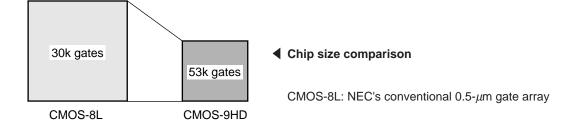
## In Pursuit of Lower Cost

- Enhanced cost competitiveness through chip-size shrinkage
- Fewer gate masters leading to further cost reduction

(Example) Comparison with CMOS-8L

Although the 30k-gate CMOS-8L and the 53k-gate CMOS-9HD are similar in terms of price, because the cell density is higher in the CMOS-9HD, for an area of 30k integrated gates or more, the CMOS-9HD is the more cost-competitive choice.

Note that the applicable-package pin-count range differs depending on the chip size, even if the gate scale is identical.



## **Ultra High-Speed Operation**

- tpd = 131 ps (2-input NAND, fanout = 1, standard wiring length)
- tpd = 107 ps (2-input NAND (power gate), fanout = 1, standard wiring length)
- tpd = 229 ps (input buffer, fanout = 1, standard wiring length)
- tpd = 222 ps (input buffer, standard load)
- tPD = 1396 ps (output buffer, CL = 50 pF)

## **Provision of Function Block Enabling High Speed/High Integration**

- Including high speed and low power, compatible with CMOS-8L Family
- · Scan path block
- Driver for clock tree synthesis
- Asynchronous single-port RAM (45 types)
- Asynchronous dual-port RAM (45 types)
- · Asynchronous compiled single-port RAM
- Synchronous/asynchronous compiled dual-port RAM

## **Abundance of Peripheral Blocks**

- LVTTL/TTL 5-V withstand voltage interface buffer
- LVTTL interface buffer with fail safe function
- High drive capacity buffer (IoL = 24 mA)
- PCI
- GTL+

- Low-noise buffer
- Buffers with on-chip pull-up resistors (5 k $\Omega$ , 50 k $\Omega$ )
- Buffers with on-chip pull-down resistors (50 kΩ)
- Digital PLL (33 to 80 MHz)
- Digital PLL (multiple)

## **Power Consumption**

• 0.524  $\mu$ W/MHz/cell (Internal gates, V<sub>DD</sub> = 3.3 V)

## **Support of Variety of Pin Count Packages**

- 100- to 304-pin plastic QFP (fine-pitch)
- 160-pin, 208-pin plastic QFP (fine-pitch, with heat spreader)
- 48- to 120-pin plastic TQFP
- 144-pin plastic LQFP
- 225- to 352-pin plastic BGA
- 108- to 304-pin plastic FBGA
- 256- to 696-pin tape BGA (with heat spreader)

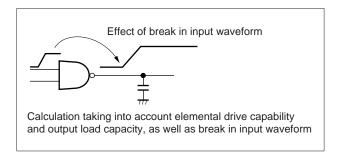
## **Precision Delay Estimation**

### <Wiring length calculation>

- Can be calculated using a floorplan
- Floorplan-calculated wiring length can be used in logic synthesis and design rule check programs

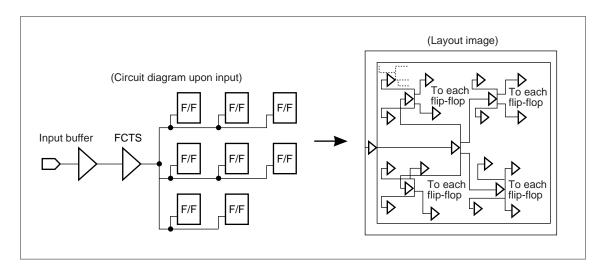
### <Delay calculation>

• Takes into account the break in the block's input waveform



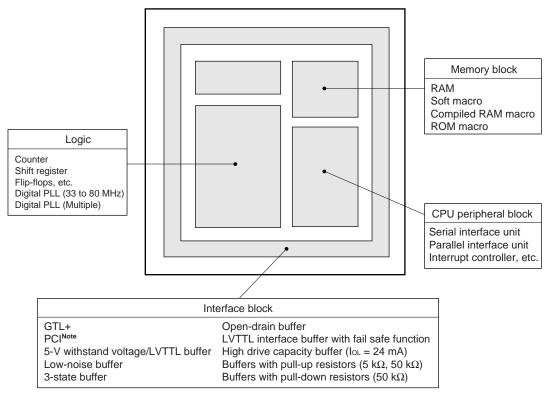
## **Clock Tree Synthesis**

- Clock tree automatically synthesized during layout to minimize clock skew
- Up to 10000 flip-flops can be connected



## **Multifarious Function Block Mounting Capability**

The function blocks ensure functional compatibility with conventional products and facilitate transfer or appropriation of existing design data.



Note Standard interface recommended by Intel Corp. (PCI = Peripheral Component Interconnect)

## **Applications (Supported Fields)**

All fields from large-scale high-speed processing systems to small and medium scale general applications are covered.

- Multimedia market
  - PC, AV, moving picture processing, 3D, etc.
- Communications market
   High-speed communication, cellular terminals, etc.
- OA, industrial, and other applications.

# PRODUCT OUTLINE

## **List of Product Types**

## 3-layer wiring

Part Number	μPD65943	μPD65944	μPD65945	μPD65946	μPD65948	μPD65949	μPD65951	μPD65954	μPD65956	μPD65958
Number of signals	156	180	200	252	308	364	416	496	572	692
Number of pads	172	196	216	268	324	380	436	516	588	708
Number of integrated gates	75740	100602	128338	202630	312684	437136	585390	835664	1096452	1615646
Number of usable gates	53018	70421	89836	141841	218879	262281	321964	459615	603048	807823

Remark The actual number of usable signal lines depends on the package and the number of power supply and GND pins used.

## 4-layer wiring

Part Number	μPD65961	μPD65964	μPD65966	μPD65968	μPD65969	μPD65970	μPD65971
Number of signals	-	-	-	_	-	-	-
Number of pads	436	516	588	708	764	820	876
Number of integrated gates	585390	835664	1096452	1615646	1904700	2196592	2509284
Number of usable gates	380503	54318	712693	969387	1142820	1317955	1505570

Remark The actual number of usable signal lines depends on the package and the number of power supply and GND pins used.

## **List of Packages**

3-layer wiring (1/2)

Package	Pins	μPD65943	μPD65944	μPD65945	μPD65946	μPD65948
Plastic QFP (fine-pitch)	100	✓	1	1	1	✓
	120	-	_	_	✓	_
	144	✓	1	1	1	✓
	160	✓	✓	✓	✓	✓
	176	_	✓	✓		
	208	-	-	1	1	✓
	240	_	_	_	✓	✓
	304	_	_	_	_	✓
Plastic QFP (fine-pitch)Note	160	-	_	_	_	_
	208	_	_	_	_	_
Plastic TQFP	48		_	_	_	_
	64		_	_	_	_
	80	✓				_
	100	✓	_	_	_	✓
	120		-	_	1	
Plastic LQFP	144	_	_	_	_	1
Plastic BGA	225	-	_	_		
	256	-	-	_	_	✓
	272	_	_	_	_	
	313	-	_	_	_	_
	352	-	_	_	_	_
Plastic FBGA	108					
	144					
	160					
	176	-	/	1		
	208	-	_	_	_	_
	240	_	_	_	_	_
	304	_	_	_	_	_
Plastic BGA (advanced)	672	-	_	_	_	_
Tape BGA <sup>Note</sup>	256	-	-	_	1	✓
	352	_	_	_	_	_
	420	-	_	_	_	_
	500	-	_	_	_	_
	576	-	_	_	_	_
	696	_	_	_	_	_

Note With heat spreader

**Remark** ✓: Supported, –: Not supported, Blank: Under consideration

## **List of Packages**

3-layer wiring (2/2)

Package	Pins	μPD65949	μPD65951	μPD65954	μPD65956	μPD65958
Plastic QFP (fine-pitch)	100	✓	1	✓	_	_
	120	-	_	_	_	_
	144	✓	✓	_	_	_
	160	✓	✓	✓	1	_
	176					_
	208	✓	1	1	1	1
	240	✓	/	/	1	1
	304	_	1	✓	1	1
Plastic QFP (fine-pitch) Note	160					
	208					
Plastic TQFP	48	-	_	_	_	_
	64	_	-	_	_	_
	80	-	_	_	_	_
	100	✓	_	_	_	_
	120		_	_	_	_
Plastic LQFP	144		_	_	_	_
Plastic BGA	225					_
	256	✓	/			_
	272	✓	✓		_	_
	313	✓	✓			
	352	✓	✓			1
Plastic FBGA	108	-	_	_	_	_
	144			_	_	_
	160			_	_	_
	176					_
	208	✓				_
	240	_				
	304	_	_	_		
Plastic BGA (advanced)	672	-	_	_	_	1
Tape BGA Note	256	✓	1		_	_
	352	✓	1	1	1	_
	420	-	✓	✓	1	✓
	500	-	_	✓	1	✓
	576	-	_	_	1	✓
	696	-	_	_	_	✓

Note With heat spreader

**Remark** ✓: Supported, –: Not supported, Blank: Under consideration

## **List of Packages**

4-layer wiring (1/2)

Package	Pins	μPD65961	μPD65964	μPD65966	μPD65968	μPD65969
Plastic QFP (fine-pitch)Note	160	_	_	_	_	_
	208					
Tape BGA <sup>Note</sup>	256	-	_	_	_	_
	352					_
	420					
	500	_				
	576	_	_			
	696	_	_			
Plastic BGA (advanced)	672	_	_	_		

Note With heat spreader

**Remark** –: Not supported, Blank: Under consideration

## 4-layer wiring

(2/2)

Package	Pins	μPD65970	μPD65971
Plastic QFP (fine-pitch)Note	160	_	_
	208		
Tape BGA <sup>Note</sup>	256	_	-
	352		
	420		
	500		
	576		
	696		
Plastic BGA (advanced)	672		

Note With heat spreader

**Remark** –: Not supported, Blank: Under consideration

# **ELECTRICAL SPECIFICATIONS**

## **Absolute Maximum Ratings**

Parameter	Symbol	Conditions	Ratings	Unit
Supply voltage	V <sub>DD</sub>		-0.5 to +4.6	V
Input voltage				
LVTTL interface buffer	Vı	VI < VDD + 0.5 V	-0.5 to +4.6	V
LVTTL interface buffer	Vı	VI < VDD + 0.5 V	-0.5 to +4.6	V
with fail safe function				
TTL 5-V withstand voltage interface buffer	Vı	VI < VDD + 3.0 V	-0.5 to +6.6	V
Output voltage				
LVTTL output buffer	Vo	Vo < VDD + 0.5 V	-0.5 to +4.6	V
TTL 5-V output buffer	Vo	Vo < VDD + 3.0 V	-0.5 to +6.6	V
5-V output buffer for CMOS	Vo	Vo < VDD + 3.0 V	-0.5 to +6.6	V
Input/output voltage	Vı/Vo	Normal I/O pin	-0.5 to V <sub>DD</sub> + 0.5	V
Output currentNote	lo	IoL = 1 mA (FV0A)	3	mA
		IoL = 2 mA (FV0B)	7	mA
		IoL = 3 mA (FO09)	10	mA
		IoL = 6 mA (FO04)	20	mA
		IoL = 9 mA (FO01)	30	mA
		loL = 12 mA (FO02)	40	mA
		IoL = 18 mA (FO03)	60	mA
		IoL = 24 mA (FO06)	75	mA
Operating ambient temperature	TA		-40 to +85	°C
Storage temperature	T <sub>stg</sub>		-65 to +150	°C

Note Output current: Indicates the maximum value of the current that is allowed to flow directly through this output pin.

Remark With the exception of the buffer with fail safe function, be sure to input voltage to the I/O pins only after the supply voltage has been fixed.

# **Recommended Operating Range**

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Supply voltage	V <sub>DD</sub>	LVTTL interface	3.00	3.30	3.60	V
High-level input voltage	ViH		2.0		Vdd	V
Low-level input voltage	VIL		0		0.8	V
Positive trigger voltage	VP		1.4		2.4	V
Negative trigger voltage	Vn		0.8		1.6	V
Hysteresis voltage	Vн		0.3		1.5	V
High-level input voltage	ViH	TTL 5-V withstand voltage	2.0		5.5	V
Low-level input voltage	VIL	interface	0		0.8	V
Positive trigger voltage	VP		1.4		2.4	V
Negative trigger voltage	Vn		0.8		1.6	V
Hysteresis voltage	Vн		0.3		1.5	V
Input rise time	tri	Normal input	0		200	ns
Input fall time	tfi		0		200	ns
Input rise time	tri	Schmitt input	0		10	ms
Input fall time	tfi		0		10	ms

## DC Characteristics (VDD = $3.3 \text{ V} \pm 0.3 \text{ V}$ )

(1/3)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Static current consumptionNote 1						
μPD65943, μPD65944,	IDDS	$V_I = V_{DD}$ or $GND$		2.0	300	μΑ
μPD65945, μPD65946,						
μPD65948, μPD65949,						
μPD65951, μPD65954,	IDDS	$V_I = V_{DD}$ or $GND$		0	400	μΑ
μPD65956						
μPD65958	Idds	VI = VDD or GND		4.0	800	μΑ
Off-state output currentNote 2						
LVTTL output	loz	Vo = VDD or GND			±10	μΑ
TTL 5-V withstand voltage output	loz	Vo = VDD or GND			±10	μΑ
5-V withstand voltage for CMOS	loz	Vo = VDD or GND			±10	μΑ
Output current flowNote 3	lR	$V_{PU} = 5.5 \text{ V}, \text{Rpu} = 2 \text{ k}\Omega,$			0.1	μΑ
5-V output for CMOS		Vo = 3.0 V				
Output short-circuit currentNote 4	los	Vo = GND			-250	mA
Input leakage current						
Normal input	lı	VI = VDD or GND			±1.0	μΑ
With pull-up resistor (50 k $\Omega$ )	lı .	Vı = GND	-28	-83	-190	μΑ
With pull-up resistor (5 kΩ)	lı	Vı = GND	-280	-700	-1900	μΑ
With pull-down resistor (50 kΩ)	lı	VI = VDD	28	83	190	μΑ
Pull-up resistor 50 kΩ	Rpu		18.9	39.8	107.1	kΩ
Pull-up resistor 5 kΩ	Rpu		1.9	4.7	10.7	kΩ
Pull-down resistor 50 kΩ	Rpd		18.9	39.8	107.1	kΩ

Notes 1. When using I/O blocks (etc.) with pull-up/pull-down resistors incorporated, the static current consumption increases.

- 2. Because there is a bias toward the 5-V protection circuit in the TTL 5-V withstand voltage and 5-V withstand voltage for CMOS 3-state or I/O buffers, the output-off state current increases slightly.
- 3. When the LSI supply current is pulled up to a higher voltage in the CMOS output buffer, a current that flows from the output pin to inside the LSI is generated.
- 4. The output short-circuit time is less than 1 second and for 1 LSI pin only.
- Remarks 1. The + and symbols attached to the current values in the table indicate the direction of the current. The symbol is + when the current is flowing into the device, and when flowing out of the device.
  - 2. Blanks in the table indicate that the values are undergoing evaluation.

# DC Characteristics (VDD = 3.3 V $\pm$ 0.3 V)

(2/3)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Low-level output current						
3 mA buffer (FO09)	loL	LVTTL output type	3.00			mA
6 mA buffer (FO04)	loL	VoL = 0.4 V	6.00			mA
9 mA buffer (FO01)	loL		9.00			mA
12 mA buffer (FO02)	loL		12.00			mA
18 mA buffer (FO03)	loL		18.00			mA
24 mA buffer (FO06)	loL		24.00			mA
1 mA buffer (FV0A)	loL	TTL 5-V withstand voltage	1.00			mA
2 mA buffer (FV0B)	loL	output type VoL = 0.4 V	2.00			mA
3 mA buffer (FV09)	loL		3.00			mA
6 mA buffer (FV04)	loL		6.00			mA
9 mA buffer (FV01)	loL		9.00			mA
12 mA buffer (FV02)	loL		12.00			mA
18 mA buffer (FV03)	loL		18.00			mA
24 mA buffer (FV06)	loL		24.00			mA
3 mA buffer (FY09)	loL	5-V withstand voltage output	3.00			mA
6 mA buffer (FY04)	loL	for CMOS type	6.00			mA
9 mA buffer (FY01)	loL	VoL = 0.4 V	9.00			mA
12 mA buffer (FY02)	loL		12.00			mA
18 mA buffer (FY03)	loL		18.00			mA
24 mA buffer (FY06)	Іоь		24.00			mA

# DC Characteristics (VDD = 3.3 V $\pm$ 0.3 V)

(3/3)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
High-level output current						
3 mA buffer (FO09)	Іон	LVTTL output type	-3.00			mA
6 mA buffer (FO04)	Іон	Vон = 2.4 V	-6.00			mA
9 mA buffer (FO01)	Іон		-9.00			mA
12 mA buffer (FO02)	Іон		-12.00			mA
18 mA buffer (FO03)	Іон		-18.00			mA
24 mA buffer (FO06)	Іон		-24.00			mA
1 mA buffer (FV0A)	Іон	TTL 5-V withstand voltage	-1.00			mA
2 mA buffer (FV0B)	Іон	output type	-1.00			mA
3 mA buffer (FV09)	Іон	Vон = 2.4 V	-3.00			mA
6 mA buffer (FV04)	Іон		-3.00			mΑ
9 mA buffer (FV01)	Іон		-3.00			mA
12 mA buffer (FV02)	Іон		-3.00			mA
18 mA buffer (FV03)	Іон		-6.00			mA
24 mA buffer (FV06)	Іон		-6.00			mA
_ow-level output voltage						
LVTTL output type	Vol	IoL = 0 mA			0.1	V
LVTTL output type (with 5 kΩ pull-up resistor)	Vol	IoL = 0 mA			0.2	V
TTL 5-V withstand voltage output type	Vol	IoL = 0 mA			0.1	V
5-V withstand voltage output for CMOS type	Vol	IoL = 0 mA			0.1	V
High-level output voltage						
LVTTL output type	Vон	Iон = 0 mA	V <sub>DD</sub> - 0.1			V
TTL 5-V withstand voltage output type	Vон	Iон = 0 mA	V <sub>DD</sub> - 0.2			V

## **AC Characteristics**

The values in the table below refer to when the supply voltage of the internal gate array block is 3.3 V.

Parameter	Symbol		Conditions	MIN.	TYP.	MAX.	Unit
Toggle frequency	ftog	Internal toggl	e F/F (fanout = 2)	670			MHz
Propagation delay time	<b>t</b> PD	Internal gates	Fanout = 1, wiring length 0 mm		94		ps
			Fanout = 1, standard wiring length		131		ps
		Internal gates, power gates,	Standard load		108		ps
			Fanout = 1, standard wiring length		107		ps
			Standard load		94		ps
		Input buffers	Fanout = 1, standard wiring length		229		ps
			Standard load		222		ps
		Output buffer		1396		ps	
Output rise time	tr	Output buffer	(FO01) C <sub>L</sub> = 15 pF		2391		ps
Output fall time	tf	Output buffer	(FO01) C <sub>L</sub> = 15 pF		1872		ps

Remark Standard load: Fanout = 2, wiring length 0 mm

# **TEST DESIGN**

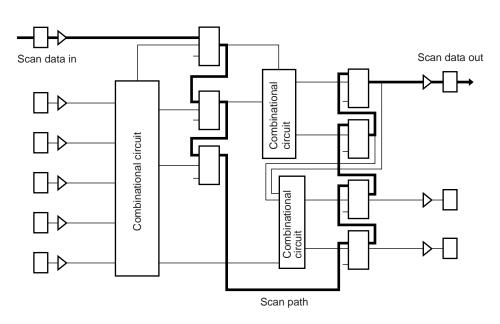
## **Scan Path Test**

The scan path test is an effective technique in test simplification design. The ATG (Automatic Testpattern Generator) makes it possible to automatically generate a test pattern with high fault coverage.

The features of NEC's scan path test are outlined below.

- · Automatic configuration of scan path
- Faults of asynchronous clock detectable
- Check tools for scan path design rule fully provided

#### **Outline of Scan Path Test Method**



# **DEVELOPMENT TOOLS**

## Easy interface with your EWS or PC

Users can choose the following tools to their environment.

Caution Some functions may not be supported. Make it sure before use.

## **OPENCAD™ V5.3 Configuration Tool**

Function	NEC Tool	Interface Data	Commercially Available Tool Interface
Function simulator	_		ModelSim <sup>™ Note 1</sup> /Verilog-XL™/VCS™
Schematic editor	Vdraw <sup>™ Note 1</sup>	Net list	_
Logic synthesis	_	PWC/EDIF (2.0.0)/	Design Compiler™
Gate-level simulator Note 2	V. sim <sup>™ Note 1</sup>	Verilog HDL	ModelSim <sup>Note 1</sup> /Verilog-XL/VCS
Formal verifier	_		Formality™
STA <sup>Note 2</sup>	Tiara <sup>Note 1</sup>	Test pattern	PrimeTime™
Fault simulationNote 3	C. FGRADE™	ALBA/LOGPAT	-
Design for test	NEC_SCAN		Testgen™ Note 4
Floor plannerNote 4	ace_floorplan	Delay data SDF	_
	galet_floorplan		
Layout and wiringNotes 3, 4	Galet	Timing limit	Gate Ensemble™
			Silicon Ensemble™

**Notes 1.** Tool supported in the Windows NT™ version

2. Sign-off tool

**3.** Tool not supported in the HP™ version

4. Individually supported tool

Remark Platform: SUN™ (Solaris™)/HP (HP-UX™)/PC-9800 series (Windows NT)/IBM PC/AT™

(Windows NT)

GUI : X11R5/Motif<sup>TM</sup> 1.2/Windows NT

OPENCAD, Vdraw, V. sim and C. FGRADE are trademarks of NEC Corporation.

Verilog-XL, Gate Ensemble and Silicon Ensemble are trademarks of Cadence Design Systems, Inc.

ModelSim is a trademark of Model Technology Inc.

VCS, Design Compiler, Formality, PrimeTime and Testgen are trademarks of Synopsys, Inc.

Windows NT is either registered trademark or trademark of Microsoft Corporation in the United States and/or other countries.

HP and HP-UX are trademarks of Hewlett-Packard Co.

SUN and Solaris are trademarks of SUN Microsystems, Inc.

PC/AT is a trademark of IBM Corporation.

Motif is a trademark of Open Software Foundation, Inc. (OSF).

The export of this product from Japan is regulated by the Japanese government. To export this product may be prohibited without governmental license, the need for which must be judged by the customer. The export or re-export of this product from a country other than Japan may also be prohibited without a license from that country. Please call an NEC sales representative.

- The information in this document is current as of April, 2000. The information is subject to change
  without notice. For actual design-in, refer to the latest publications of NEC's data sheets or data
  books, etc., for the most up-to-date specifications of NEC semiconductor products. Not all products
  and/or types are available in every country. Please check with an NEC sales representative for
  availability and additional information.
- No part of this document may be copied or reproduced in any form or by any means without prior written consent of NEC. NEC assumes no responsibility for any errors that may appear in this document.
- NEC does not assume any liability for infringement of patents, copyrights or other intellectual property rights of
  third parties by or arising from the use of NEC semiconductor products listed in this document or any other
  liability arising from the use of such products. No license, express, implied or otherwise, is granted under any
  patents, copyrights or other intellectual property rights of NEC or others.
- Descriptions of circuits, software and other related information in this document are provided for illustrative
  purposes in semiconductor product operation and application examples. The incorporation of these
  circuits, software and information in the design of customer's equipment shall be done under the full
  responsibility of customer. NEC assumes no responsibility for any losses incurred by customers or third
  parties arising from the use of these circuits, software and information.
- While NEC endeavours to enhance the quality, reliability and safety of NEC semiconductor products, customers
  agree and acknowledge that the possibility of defects thereof cannot be eliminated entirely. To minimize
  risks of damage to property or injury (including death) to persons arising from defects in NEC
  semiconductor products, customers must incorporate sufficient safety measures in their design, such as
  redundancy, fire-containment, and anti-failure features.
- NEC semiconductor products are classified into the following three quality grades:
  - "Standard", "Special" and "Specific". The "Specific" quality grade applies only to semiconductor products developed based on a customer-designated "quality assurance program" for a specific application. The recommended applications of a semiconductor product depend on its quality grade, as indicated below. Customers must check the quality grade of each semiconductor product before using it in a particular application.
  - "Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots
  - "Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)
  - "Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.

The quality grade of NEC semiconductor products is "Standard" unless otherwise expressly specified in NEC's data sheets or data books, etc. If customers wish to use NEC semiconductor products in applications not intended by NEC, they must contact an NEC sales representative in advance to determine NEC's willingness to support a given application.

(Note)

- (1) "NEC" as used in this statement means NEC Corporation and also includes its majority-owned subsidiaries.
- (2) "NEC semiconductor products" means any semiconductor product developed or manufactured by or for @NEC (as defined above).

M8E 00.4

### For further information, please contact:

#### **NEC Corporation**

NEC Building 7-1, Shiba 5-chome, Minato-ku Tokyo 108-8001, Japan Tel: 03-3454-1111 http://www.ic.nec.co.jp/

#### [North & South America]

#### **NEC Electronics Inc.**

2880 Scott Blvd. Santa Clara, CA 95050-2554, U.S.A. Tel: 408-588-6000 800-366-9782

Fax: 408-588-6130 800-729-9288 http://www.necel.com/

#### NEC do Brasil S.A.

Electron Devices Division Rodovia Presidente Dutra, Km 214 07210-902-Guarulhos-SP Brasil

Tel: 55-11-6465-6810 Fax: 55-11-6465-6829

#### [Europe]

#### **NEC Electronics (Germany) GmbH**

Kanzlerstr. 2, 40472 Düsseldorf Germany Tel: 0211-650302

Fax: 0211-6503490 http://www.nec.de/

#### **Munich Office**

Arabellastr. 17 81925 München, Germany Tel: 089-921003-0 Fax: 089-92100315

#### Stuttgart Office

Industriestr. 3 70507 Stuttgart, Germany Tel: 0711-99010-0 Fax: 0711-99010-19

#### **Hannover Office**

Podbielskistr. 164 D-30177 Hannover, Germany Tel: 0511-33402-0

Tel: 0511-33402-0 Fax: 0511-33402-34

#### **Benelux Office**

Boschdijk 187a 5612 HB Eindhoven, The Netherlands Tel: 040-2445845 Fax: 040-2444580

### Scandinavia Office

P.O. Box 134 18322 Taeby, Sweden Tel: 08-6380820 Fax: 08-6380388

#### **NEC Electronics (UK) Limited**

Cygnus House, Sunrise Park Way, Milton Keynes, MK14 6NP, U.K.

Tel: 01908-691-133 Fax: 01908-670-290

#### **NEC Electronics (France) S.A.**

9, rue Paul Dautier-BP 187 78142 Velizy-Villacoublay Cédex France

Tel: 01-30-67-58-00 Fax: 01-30675899

#### **Madrid Office**

Juan Esplandiu, 15 28007 Madrid, Spain Tel: 91-504-2787 Fax: 91-504-2860

#### NEC Electronics Italiana s.r.l.

Via Fabio Filzi, 25/A, 20124 Milano, Italy Tel: 02-667541 Fax: 02-66754299

#### [Asia & Oceania]

#### **NEC Electronics Hong Kong Limited**

12/F., Cityplaza 4, 12 Taikoo Wan Road, Hong Kong Tel: 2886-9318

Fax: 2886-9022/9044

#### Seoul Branch

10F, ILSONG Bldg., 157-37, Samsung-Dong, Kangnam-Ku Seoul, the Republic of Korea Tel: 02-528-0303

Fax: 02-528-4411

#### **NEC Electronics Taiwan Ltd.**

7F, No. 363 Fu Shing North Road Taipei, Taiwan, R. O. C. Tel: 02-2719-2377 Fax: 02-2719-5951

### **NEC Electronics Singapore Pte. Ltd.**

101 Thomson Road #04-01/05 United Square, Singapore 307591

Tel: 65-253-8311 Fax: 65-250-3583

G99. 11

Document No. A12852EJ3V0PF00(3rd edition)
Date Published June 2000 N CP(K)

© NEC Corporation 1997 Printed in Japan

This datasheet has been download from:

www.datasheetcatalog.com

Datasheets for electronics components.